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| FORM PTO-1449 | APPLICATION NO. 10/655,175 | CASE NO. 10541-1841 (V203-0245) |
| LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT | FILING DATE September 3, 2003 | ART UNIT |
| APPLICANT(S): Glenn E. Tomford, et al. | | |

REFERENCE DESIGNATION

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| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS/ SUBCLASS | FILING DATE |
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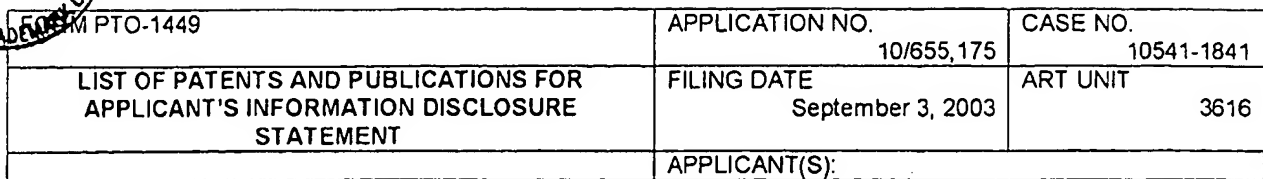
FOREIGN PATENT DOCUMENTS

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| EXAMINER INITIAL | OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.) |
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